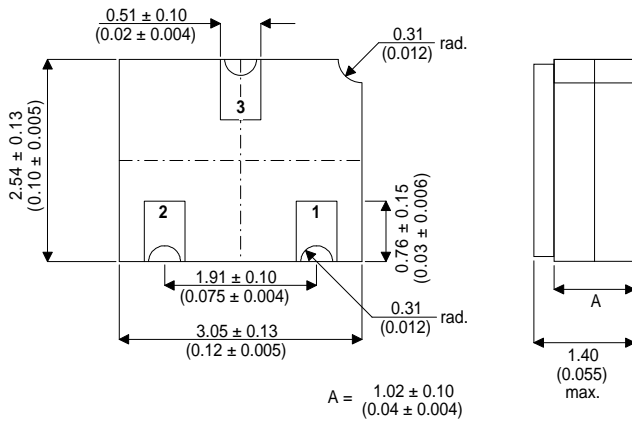


MECHANICAL DATA

Dimensions in mm (inches)



HIGH SPEED PNP SWITCHING TRANSISTOR FOR HIGH RELIABILITY APPLICATIONS

FEATURES

- SILICON PLANAR EPITAXIAL PNP TRANSISTOR
- HERMETIC CERAMIC SURFACE MOUNT PACKAGE (SOT23 COMPATIBLE)
- SCREENING OPTIONS AVAILABLE
- SPACE QUALITY LEVEL OPTIONS
- HIGH SPEED SATURATED SWITCHING

LCC1 (SOT23)

PAD 1 – Base PAD 2 – Emitter PAD 3 – Collector

APPLICATIONS

For high reliability general purpose applications requiring small size and low weight devices.

ABSOLUTE MAXIMUM RATINGS

$T_{CASE} = 25^{\circ}C$ unless otherwise stated

V_{CBO}	Collector - Base Voltage	-20V
V_{CEO}	Collector - Emitter Voltage ($I_B = 0$)	-20V
V_{EBO}	Emitter - Base Voltage ($I_C = 0$)	-4.0V
I_C	Continuous Collector Current	-200mA
P_D	Total Power Dissipation at $T_{case} \leq 25^{\circ}C$	300mW
	De-Rate above: $T_{case} \leq 50^{\circ}C$	2.20mW/ $^{\circ}C$
T_{stg}, T_J	Operating and Storage Temperature Range	-55 to +200 $^{\circ}C$

THERMAL DATA

$R_{\theta JA}$	Thermal Resistance Junction - Ambient	Max	420	$^{\circ}C/W$
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Semelab Plc reserves the right to change test conditions, parameter limits and package dimensions without notice. Information furnished by Semelab is believed to be both accurate and reliable at the time of going to press. However Semelab assumes no responsibility for any errors or omissions discovered in its use. Semelab encourages customers to verify that datasheets are current before placing orders.

ELECTRICAL CHARACTERISTICS (T_{case}=25°C unless otherwise stated)

Parameter	Test Conditions	Min.	Typ.	Max.	Unit
V _{(BR)CEO} *	Collector - Emitter Breakdown Voltage I _C = 10mA	-20	-	-	V
V _{(BR)CBO} *	Collector - Base Breakdown Voltage I _C = 10μA	-20	-	-	
V _{(BR)EBO} *	Emitter - Base Breakdown Voltage I _C = 0 I _E = 10μA	-4.0	-	-	
I _{CES} *	Collector Cut-Off Current V _{BE} = 0V V _{CE} = -10V	-	-	-80	nA
					T _C = 125°C
V _{CE(sat)} *	Collector - Emitter Saturation Voltage I _C = -10mA I _B = -1.0mA	-	-	-0.20	V
	I _C = -30mA I _B = -3mA	-	-	-0.25	
	I _C = -100mA I _B = -10mA	-	-	-0.75	
V _{BE(sat)} *	Base - Emitter Saturation Voltage I _C = -10mA I _B = -1.0mA	-0.78	-	-0.98	V
	I _C = -30mA I _B = -3mA	-0.85	-	-1.2	
	I _C = -100mA I _B = -10mA	-	-	-1.7	
h _{FE} *	DC Current Gain I _C = -10mA V _{CE} = -0.3V	25	-	-	
	I _C = -30mA V _{CE} = -0.5V	30	-	120	
	T _{AMB} = -55°C	12	-	-	
	I _C = -100mA V _{CE} = -1.0V	15	-	-	

DYNAMIC CHARACTERISTICS (T_{case}=25°C unless otherwise stated)

f _T	Transition Frequency I _C = -30mA V _{CE} = -10V f = 100MHz	400	-	-	MHz
C _{IBO}	Emitter - Base Capacitance I _C = 0 V _{EB} = -0.5V f = 1.0MHz	-	-	6.0	pF
C _{OBO}	Collector - Base Capacitance I _E = 0 V _{CB} = -5V f = 1.0MHz	-	-	5.0	pF
t _{on}	Turn-On Time V _{CC} = -2V I _C = -30mA	-	-	60	ns
t _{off}	Turn-Off Time I _{B1} = -1.5mA I _{B2} = -I _{B1}	-	-	90	

* Pulse test t_p = 300μs, δ < 2%